

checkCIF/PLATON report

Structure factors have been supplied for datablock(s) Eind-Silylene

THIS REPORT IS FOR GUIDANCE ONLY. IF USED AS PART OF A REVIEW PROCEDURE FOR PUBLICATION, IT SHOULD NOT REPLACE THE EXPERTISE OF AN EXPERIENCED CRYSTALLOGRAPHIC REFEREE.

No syntax errors found. CIF dictionary Interpreting this report

Datablock: Eind-Silylene

Bond precision:	C-C = 0.0032 Å	Wavelength=0.71073	
Cell:	a=32.720 (7)	b=18.594 (4)	c=16.662 (4)
	alpha=90	beta=104.756 (3)	gamma=90
Temperature:	100 K		

	Calculated	Reported
Volume	9803(4)	9803(4)
Space group	C 2/c	C 2/c
Hall group	-C 2yc	-C 2yc
Moiety formula	C56 H90 Si	C56 H90 Si
Sum formula	C56 H90 Si	C56 H90 Si
Mr	791.37	791.36
Dx, g cm ⁻³	1.072	1.072
Z	8	8
Mu (mm ⁻¹)	0.082	0.082
F000	3520.0	3520.0
F000'	3521.72	
h, k, lmax	42, 24, 21	42, 24, 21
Nref	11268	11249
Tmin, Tmax	0.982, 0.991	0.981, 0.993
Tmin'	0.977	

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Correction method= # Reported T Limits: Tmin=0.981 Tmax=0.993
AbsCorr = NUMERICAL
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Data completeness= 0.998 Theta (max)= 27.500

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R(reflections)= 0.0757( 8955)      wR2(reflections)=
S = 1.098                          0.1823( 11249)
Npar= 540
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The following ALERTS were generated. Each ALERT has the format

test-name_ALERT_alert-type_alert-level.

Click on the hyperlinks for more details of the test.

Alert level B

PLAT094_ALERT_2_B Ratio of Maximum / Minimum Residual Density 5.12 Report

Author Response: The crystal may contain a trace amount of water molecules that interact with the silylene moiety but this was not implemented in the refinement model due to a lack of crucial evidence for its presence.

PLAT097_ALERT_2_B Large Reported Max. (Positive) Residual Density 1.71 eA-3

Author Response: The crystal may contain a trace amount of water molecules that interact with the silylene moiety but this was not implemented in the refinement model due to a lack of crucial evidence for its presence.

Alert level C

DIFMX02_ALERT_1_C The maximum difference density is > 0.1*ZMAX*0.75

The relevant atom site should be identified.

PLAT222_ALERT_3_C	NonSolvent Resd 1	H	Uiso(max)/Uiso(min)	Range	5.1	Ratio
PLAT420_ALERT_2_C	D-H Bond Without Acceptor	Si1A	--H1	.		Please Check
PLAT906_ALERT_3_C	Large K Value in the Analysis of Variance			15.204	Check
PLAT906_ALERT_3_C	Large K Value in the Analysis of Variance			2.480	Check
PLAT911_ALERT_3_C	Missing FCF Refl Between Thmin & STh/L=	0.600			13	Report
	0 2 0,	2 2 0,	3 1 0,	4 0 0,	-3 1 1,	0 2 1,
	1 1 1,	2 2 1,	-2 0 2,	-1 1 2,	-1 3 3,	9 19 3,
	-20 4 5,					

Alert level G

PLAT002_ALERT_2_G	Number of Distance or Angle Restraints on AtSite	9	Note
PLAT066_ALERT_1_G	Predicted and Reported Tmin&Tmax Range Identical	?	Check
PLAT083_ALERT_2_G	SHELXL Second Parameter in WGHT Unusually Large	14.28	Why ?
PLAT128_ALERT_4_G	Alternate Setting for Input Space Group	C2/c	I2/a Note
PLAT171_ALERT_4_G	The CIF-Embedded .res File Contains EADP Records	5	Report
PLAT172_ALERT_4_G	The CIF-Embedded .res File Contains DFIX Records	2	Report
PLAT173_ALERT_4_G	The CIF-Embedded .res File Contains DANG Records	2	Report
PLAT176_ALERT_4_G	The CIF-Embedded .res File Contains SADI Records	3	Report
PLAT191_ALERT_3_G	A Non-default SADI Restraint Value has been used	0.0020	Report
PLAT191_ALERT_3_G	A Non-default SADI Restraint Value has been used	0.0020	Report
PLAT191_ALERT_3_G	A Non-default SADI Restraint Value has been used	0.0020	Report
PLAT301_ALERT_3_G	Main Residue Disorder (Resd 1)	9%	Note
PLAT410_ALERT_2_G	Short Intra H...H Contact H1 ..H13B .	2.10	Ang.
	x,y,z =	1_555	Check
PLAT410_ALERT_2_G	Short Intra H...H Contact H1 ..H15B .	1.96	Ang.
	x,y,z =	1_555	Check
PLAT410_ALERT_2_G	Short Intra H...H Contact H25A ..H55A .	1.87	Ang.
	x,y,z =	1_555	Check

PLAT410_ALERT_2_G	Short Intra H...H Contact	H32B	..H47C	.	1.93 Ang.
			x,y,z =		1_555 Check
PLAT410_ALERT_2_G	Short Intra H...H Contact	H32B	..H47D	.	2.12 Ang.
			x,y,z =		1_555 Check
PLAT410_ALERT_2_G	Short Intra H...H Contact	H43B	..H47D	.	2.11 Ang.
			x,y,z =		1_555 Check
PLAT412_ALERT_2_G	Short Intra XH3 .. XHn	H46C	..H47B	.	2.10 Ang.
			x,y,z =		1_555 Check
PLAT413_ALERT_2_G	Short Inter XH3 .. XHn	H26A	..H56F	.	2.14 Ang.
			1-x,y,1/2-z =		2_655 Check
PLAT860_ALERT_3_G	Number of Least-Squares Restraints				7 Note
PLAT910_ALERT_3_G	Missing # of FCF Reflection(s) Below Theta(Min).				2 Note
	1 1 0, 2 0 0,				
PLAT912_ALERT_4_G	Missing # of FCF Reflections Above STh/L= 0.600				3 Note
PLAT913_ALERT_3_G	Missing # of Very Strong Reflections in FCF				3 Note
	0 2 0, -3 1 1, -1 3 3,				
PLAT933_ALERT_2_G	Number of HKL-OMIT Records in Embedded .res File				2 Note
	0 2 0, -2 0 2,				
PLAT941_ALERT_3_G	Average HKL Measurement Multiplicity				3.6 Low
PLAT967_ALERT_5_G	Note: Two-Theta Cutoff Value in Embedded .res ..				55.0 Degree
PLAT969_ALERT_5_G	The 'Henn et al.' R-Factor-gap value				4.15 Note
	Predicted wR2: Based on SigI**2 4.40 or SHELX Weight 17.01				
PLAT978_ALERT_2_G	Number C-C Bonds with Positive Residual Density.				6 Info

0 **ALERT level A** = Most likely a serious problem - resolve or explain
 2 **ALERT level B** = A potentially serious problem, consider carefully
 6 **ALERT level C** = Check. Ensure it is not caused by an omission or oversight
 29 **ALERT level G** = General information/check it is not something unexpected

2 ALERT type 1 CIF construction/syntax error, inconsistent or missing data
 15 ALERT type 2 Indicator that the structure model may be wrong or deficient
 12 ALERT type 3 Indicator that the structure quality may be low
 6 ALERT type 4 Improvement, methodology, query or suggestion
 2 ALERT type 5 Informative message, check

It is advisable to attempt to resolve as many as possible of the alerts in all categories. Often the minor alerts point to easily fixed oversights, errors and omissions in your CIF or refinement strategy, so attention to these fine details can be worthwhile. In order to resolve some of the more serious problems it may be necessary to carry out additional measurements or structure refinements. However, the purpose of your study may justify the reported deviations and the more serious of these should normally be commented upon in the discussion or experimental section of a paper or in the "special_details" fields of the CIF. checkCIF was carefully designed to identify outliers and unusual parameters, but every test has its limitations and alerts that are not important in a particular case may appear. Conversely, the absence of alerts does not guarantee there are no aspects of the results needing attention. It is up to the individual to critically assess their own results and, if necessary, seek expert advice.

Publication of your CIF in IUCr journals

A basic structural check has been run on your CIF. These basic checks will be run on all CIFs submitted for publication in IUCr journals (*Acta Crystallographica*, *Journal of Applied Crystallography*, *Journal of Synchrotron Radiation*); however, if you intend to submit to *Acta Crystallographica Section C* or *E* or *IUCrData*, you should make sure that full publication checks are run on the final version of your CIF prior to submission.

Publication of your CIF in other journals

Please refer to the *Notes for Authors* of the relevant journal for any special instructions relating to CIF submission.

